# **BUK9E06-55A**

## N-channel TrenchMOS logic level FET

Rev. 04 — 31 May 2010

**Product data sheet** 

### 1. Product profile

### 1.1 General description

Logic level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

#### 1.2 Features and benefits

- Low conduction losses due to low on-state resistance
- Q101 compliant

- Suitable for logic level gate drive sources
- Suitable for thermally demanding environments due to 175 °C rating

### 1.3 Applications

- 12 V and 24 V loads
- Automotive and general purpose power switching

Motors, lamps and solenoids

#### 1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
$V_{DS}$	drain-source voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}$		-	-	55	V
I <sub>D</sub>	drain current	$V_{GS} = 5 \text{ V}; T_j = 25 \text{ °C};$ see <u>Figure 3</u> ; see <u>Figure 1</u>	[1]	-	-	75	Α
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>		-	-	300	W
Static char	acteristics						
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A};$ $T_j = 25 \text{ °C}$		-	4.8	5.8	mΩ
		$V_{GS} = 4.5 \text{ V}; I_D = 25 \text{ A};$ $T_j = 25 \text{ °C}$		-	-	6.7	mΩ
		$V_{GS} = 5 \text{ V}; I_D = 25 \text{ A};$ $T_j = 25 \text{ °C};$ see <u>Figure 12;</u> see <u>Figure 13</u>		-	5.3	6.3	mΩ
Avalanche	ruggedness						
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	$I_D$ = 75 A; $V_{sup} \le$ 55 V; $R_{GS}$ = 50 $\Omega$ ; $V_{GS}$ = 5 V; $T_{j(init)}$ = 25 °C; unclamped		-	-	1.1	J



[1] Continuous current is limited by package.

## 2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		_
2	D	drain	mb	D
3	S	source		G (EA)
mb	D	mounting base; connected to drain	1 2 3	mbb076 S
			SOT226 (I2PAK)	

## 3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
BUK9E06-55A	I2PAK	plastic single-ended package (I2PAK); TO-262	SOT226

## 4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
$V_{DS}$	drain-source voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C		-	-	55	V
$V_{DGR}$	drain-gate voltage	$R_{GS} = 20 \text{ k}\Omega$		-	-	55	V
$V_{GS}$	gate-source voltage			-15	-	15	V
I <sub>D</sub>	drain current	V <sub>GS</sub> = 5 V; T <sub>j</sub> = 25 °C;	<u>[1]</u>	-	-	154	Α
		see Figure 3; see Figure 1	[2]	-	-	75	Α
		$V_{GS} = 5 \text{ V}; T_j = 100 \text{ °C}; \text{ see } \frac{\text{Figure 1}}{}$	[2]	-	-	75	Α
I <sub>DM</sub>	peak drain current	$T_{mb}$ = 25 °C; $t_p \le 10 \mu s$ ; pulsed; see <u>Figure 3</u>		-	-	616	Α
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>		-	-	300	W
T <sub>stg</sub>	storage temperature			-55	-	175	°C
Tj	junction temperature			-55	-	175	°C
Source-drain	diode						
Is	source current	T <sub>mb</sub> = 25 °C	<u>[1]</u>	-	-	154	Α
			[2]	-	-	75	Α
I <sub>SM</sub>	peak source current	$t_p \le 10 \ \mu s$ ; pulsed; $T_{mb} = 25 \ ^{\circ}C$		-	-	616	Α
Avalanche rug	ggedness						
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	$I_D$ = 75 A; $V_{sup} \le$ 55 V; $R_{GS}$ = 50 $\Omega$ ; $V_{GS}$ = 5 V; $T_{j(init)}$ = 25 °C; unclamped		-	-	1.1	J

<sup>[1]</sup> Current is limited by power dissipation chip rating.

<sup>[2]</sup> Continuous current is limited by package.

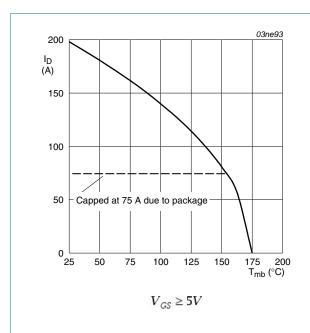


Fig 1. Normalized continuous drain current as a function of mounting base temperature

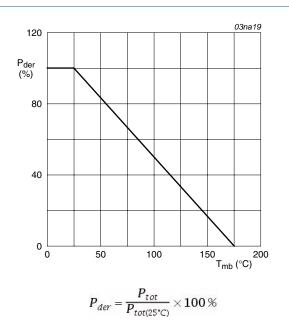
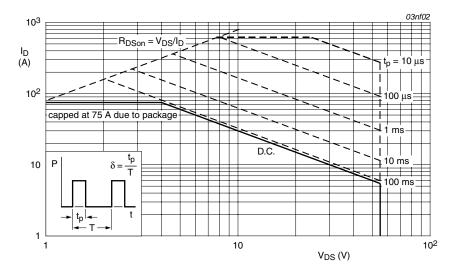


Fig 2. Normalized total power dissipation as a function of mounting base temperature



 $T_{mb} = 25$ °C;  $I_{DM}$ is single pulse

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

### 5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R <sub>th(j-mb)</sub>	thermal resistance from junction to mounting base	see Figure 4	-	-	0.5	K/W
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient	vertical in still air	-	60	-	K/W

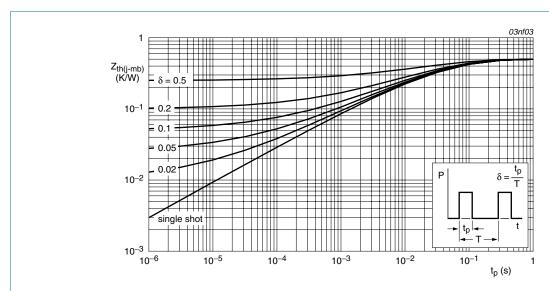


Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration

### 6. Characteristics

Table 6. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	acteristics					
V <sub>(BR)DSS</sub>	drain-source	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	55	-	-	V
	breakdown voltage	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = -55 \text{ °C}$	50	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = 25$ °C; see Figure 11	1	1.5	2	V
		$I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = -55$ °C; see Figure 11	-	-	2.3	V
		$I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = 175$ °C; see Figure 11	0.5	-	-	V
I <sub>DSS</sub> drain	drain leakage current	$V_{DS} = 55 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ °C}$	-	-	500	μΑ
		$V_{DS} = 55 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.05	10	μΑ
I <sub>GSS</sub>	gate leakage current	$V_{DS} = 0 \text{ V}; V_{GS} = 10 \text{ V}; T_j = 25 \text{ °C}$	-	2	100	nA
		$V_{DS} = 0 \text{ V}; V_{GS} = -10 \text{ V}; T_j = 25 \text{ °C}$	-	2	100	nA

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 Table 6.
 Characteristics ...continued

$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Max 13.2 5.8 6.7	Unit $mΩ$
resistance $ \begin{array}{c} \text{see } \underline{\text{Figure 12}}; \text{ see } \underline{\text{Figure 13}} \\ \\ V_{\text{GS}} = 10 \text{ V}; \text{ I}_{\text{D}} = 25 \text{ A}; \text{ T}_{\text{j}} = 25 \text{ °C} \\ \\ V_{\text{GS}} = 4.5 \text{ V}; \text{ I}_{\text{D}} = 25 \text{ A}; \text{ T}_{\text{j}} = 25 \text{ °C} \\ \\ V_{\text{GS}} = 5 \text{ V}; \text{ I}_{\text{D}} = 25 \text{ A}; \text{ T}_{\text{j}} = 25 \text{ °C}; \\ \\ \end{array} \qquad \begin{array}{c} - \\ 5.3 \end{array} $	5.8	
$V_{GS} = 4.5 \text{ V}; I_D = 25 \text{ A}; T_j = 25 ^{\circ}\text{C}$ $V_{GS} = 5 \text{ V}; I_D = 25 \text{ A}; T_j = 25 ^{\circ}\text{C};$ - 5.3		mΩ
$V_{GS} = 5 \text{ V}; I_D = 25 \text{ A}; T_j = 25 \text{ °C};$ - 5.3	6.7	
The state of the s	0.7	mΩ
see <u>Figure 12</u> ; see <u>Figure 13</u>	6.3	mΩ
Dynamic characteristics		
$C_{iss}$ input capacitance $V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz};$ - 6500	8600	pF
$C_{oss}$ output capacitance $T_j = 25$ °C; see Figure 14 - 1000	1200	pF
C <sub>rss</sub> reverse transfer - 650 capacitance	850	pF
$t_{d(on)}$ turn-on delay time $V_{DS} = 30 \text{ V}; R_L = 1.2 \Omega; V_{GS} = 5 \text{ V};$ - 45	-	ns
$t_r$ rise time $R_{G(ext)} = 10 \Omega; T_j = 25 ^{\circ}C$ - 180	-	ns
t <sub>d(off)</sub> turn-off delay time - 420	-	ns
$t_{f}$ fall time - 235	-	ns
$L_D$ internal drain from drain lead 6 mm from package to - 4.5 inductance centre of die ; $T_j = 25\ ^{\circ}C$	-	nΗ
from upper edge of drain mounting base - 2.5 to centre of die ; $T_j = 25  ^{\circ}\text{C}$	-	nΗ
$L_S$ internal source from source lead to source bond pad ; - 7.5 inductance $T_j = 25~^{\circ}C$	-	nΗ
Source-drain diode		
$V_{SD}$ source-drain voltage $I_S = 30$ A; $V_{GS} = 0$ V; $T_j = 25$ °C; - 0.85 see Figure 15	1.2	V
4	-	ns
$t_{rr}$ reverse recovery time $l_S = 20 \text{ A}$ ; $dl_S/dt = -100 \text{ A/µs}$ ; - 80 $V_{GS} = -10 \text{ V}$ ; $V_{DS} = 30 \text{ V}$ ; $V_{DS} = 25 \text{ °C}$		

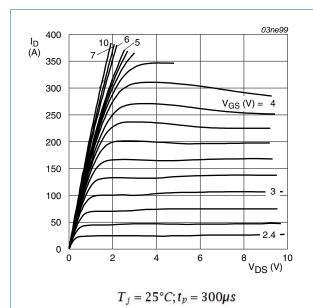


Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values

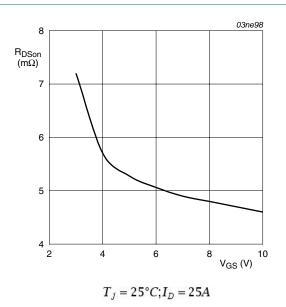


Fig 6. Drain-source on-state resistance as a function of gate-source voltage; typical values

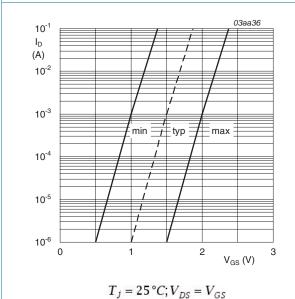


Fig 7. Sub-threshold drain current as a function of gate-source voltage

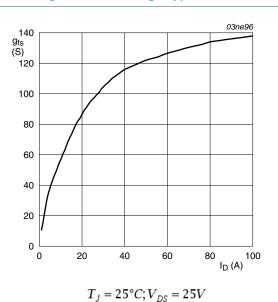


Fig 8. Forward transconductance as a function of drain current; typical values

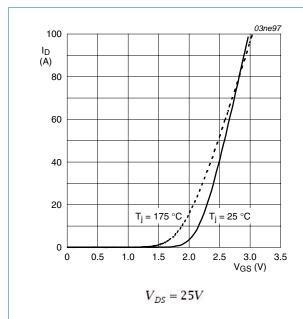


Fig 9. Transfer characteristics: drain current as a function of gate-source voltage; typical values

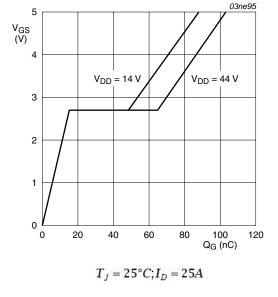


Fig 10. Gate-source voltage as a function of gate charge; typical values

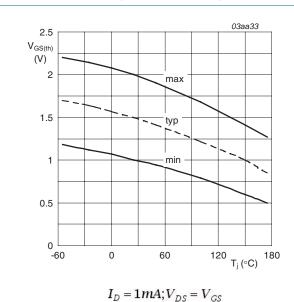


Fig 11. Gate-source threshold voltage as a function of junction temperature

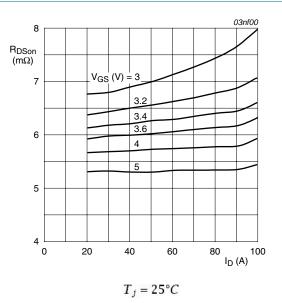


Fig 12. Drain-source on-state resistance as a function of drain current; typical values

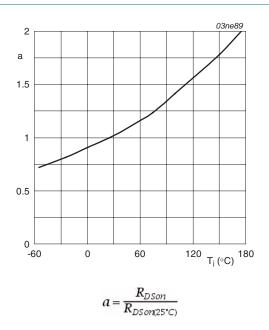
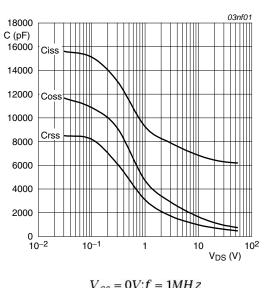


Fig 13. Normalized drain-source on-state resistance factor as a function of junction temperature



 $V_{GS} = 0V; f = 1MHz$ 

Fig 14. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

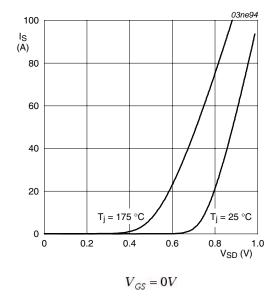


Fig 15. Reverse diode current as a function of reverse diode voltage; typical values

### 7. Package outline

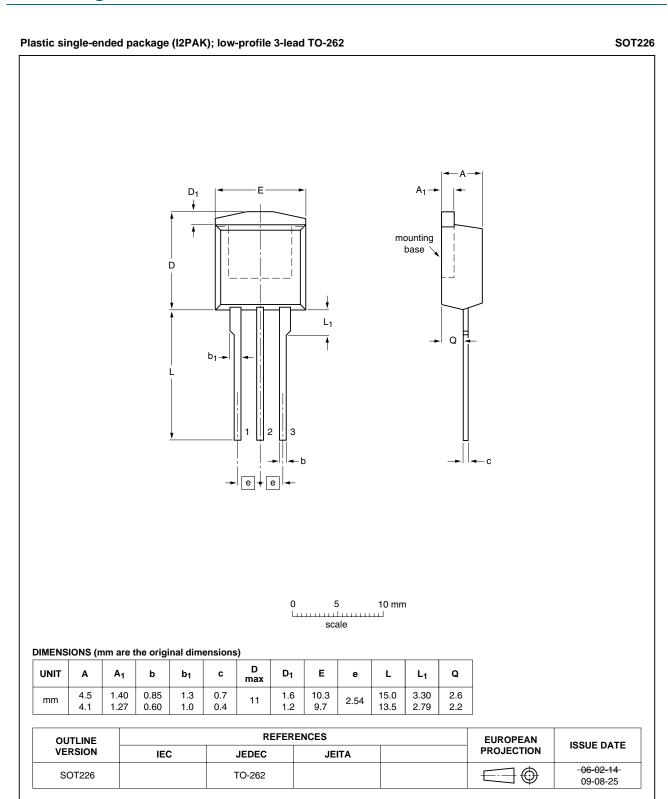


Fig 16. Package outline SOT226 (I2PAK)

## 8. Revision history

#### Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes	
BUK9E06-55A v.4	20100531	Product data sheet	-	BUK9506_9606_9E06_55A-03	
Modifications:  • The format of this data sheet has been redesigned to comply with the new ide guidelines of NXP Semiconductors.					
	<ul> <li>Legal texts</li> </ul>	s have been adapted to	the new company	name where appropriate.	
		ber BUK9E06-55A sepa _9606_9E06_55A-03.	arated from data sh	neet	
BUK9506_9606_9E06_55A-03 (9397 750 08416)	20010723	Product data sheet	-	-	

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#### 9.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
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